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Substitute for form 1449, PTO				Complete if Known	
				Application Number	10/763,987
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Filing Date	1-21-2004
				First Named Inventor	Scott Childs
				Group Art Unit	1614
				Examiner Name	Not yet assigned
				Attorney Docket Number	14245US02
Sheet	1	of	1		

U.S. PATENT DOCUMENTS					
Examiner Initial*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
YV	A1	US-5,080,832 A	01-1401992	Etter et al	
	A2				
	A3				
	A4				
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FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)				
	A13					
	A14					
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	A16					
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OTHER ART -- NON PATENT LITERATURE DOCUMENTS		
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published
YV	A18	International Search Report and Written Opinion, dated July 18, 2005, from International Application No. PCT/US04/01699.
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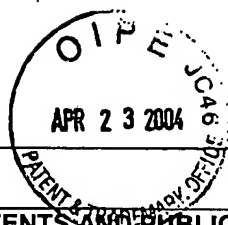
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FORM PTO-1449	SERIAL NO. 10/763,987	CASE NO. 14245US02
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	FILING DATE January 21, 2004	GROUP ART UNIT
(use several sheets if necessary)		APPLICANT(S): Scott L. Childs

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	DATE CONSIDERED	02/02/2007

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